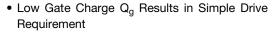


N-Channel 500V(D-S) Super Junction Power MOSFET

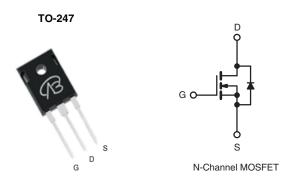
PRODUCT SUMMARY						
V _{DS} (V)	500	500				
R _{DS(on)} (Ω)	V _{GS} = 10 V	0.080				
Q _g (Max.) (nC)	350					
Q _{gs} (nC)	85	85				
Q _{gd} (nC)	180	180				
Configuration	Singl	Single				

FEATURES





- Improved Gate, Avalanche and Dynamic dV/dt Ruggedness
- Fully Characterized Capacitance and Avalanche Voltage and Current
- Low R_{DS(on)}
- Compliant to RoHS Directive 2002/95/EC



APPLICATIONS

- Switch Mode Power Supply (SMPS)
- Uninterruptible Power Supply
- High Speed Power Switching
- Hard Switched and High Frequency Circuits

ABSOLUTE MAXIMUM RATINGS (T _C = 25 °C, unless otherwise noted)						
PARAMETER Drain-Source Voltage			SYMBOL	LIMIT	UNIT	
			V_{DS}	500	.,	
Gate-Source Voltage			V _{GS}	± 30	- V	
Continuous Drain Current	V _{GS} at 10 V	T _C = 25 °C T _C = 100 °C		40	А	
Continuous Drain Current	V _{GS} at 10 V	T _C = 100 °C	I _D	25		
Pulsed Drain Current ^a			I _{DM}	180		
Linear Derating Factor				4.3	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	910	mJ	
Repetitive Avalanche Current ^a			I _{AR}	40	А	
Repetitive Avalanche Energy ^a			E _{AR}	51	mJ	
Maximum Power Dissipation	T _C = 25 °C		P _D	530	W	
Peak Diode Recovery dV/dtc	•		dV/dt	9.0	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 150		
Soldering Recommendations (Peak Temperature)	for	10 s		300 ^d	°C	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Starting T_J = 25 °C, L = 0.82 mH, R_q = 25 Ω , I_{AS} = 47 A (see fig. 12c).
- c. $I_{SD} \leq 47$ A, $dI/dt \leq 230$ A/µs, $V_{DD} \leq V_{DS}$, $T_J \leq 150$ °C.
- d. 1.6 mm from case.



THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	TYP.	MAX.	UNIT		
Maximum Junction-to-Ambient	R _{thJA}	-	40			
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.24	-	°C/W		
Maximum Junction-to-Case (Drain)	R _{thJC}	-	0.23			

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static		·					
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		500	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	ce to 25 °C, I _D = 1 mA	-	0.60	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D = 250 μA	3.0	-	5.0	V
Gate-Source Leakage	I _{GSS}		$V_{GS} = \pm 30 \text{ V}$	-	-	± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}		= 500 V, V _{GS} = 0 V V, V _{GS} = 0 V, T _J = 125 °C	-	-	50 250	μA
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 28 A ^b	-	0.080	-	Ω
Forward Transconductance	9fs		= 50 V, I _D = 28 A	23	-	_	S
Dynamic	yıs .	1 .08	- 55 1, 10 - 25 71	20			
Input Capacitance	C _{iss}	T		_	8310	_	
Output Capacitance	C _{oss}	-	$V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$ f = 1.0 MHz, see fig. 5		960	-	-
Reverse Transfer Capacitance	C _{rss}	f = 1			120	-	
	C _{oss}	V _{GS} = 0 V	V _{DS} = 1.0 V, f = 1.0 MHz	-	10170	-	pF
Output Capacitance			V _{DS} = 400 V, f = 1.0 MHz	-	240	_	
Effective Output Capacitance	C _{oss} eff.		V _{DS} = 0 V to 400 V ^c	-	440	-	
Total Gate Charge	Qq			-	-	350	†
Gate-Source Charge	Q _{gs}	$I_D = 47 \text{ A}, V_{DS} = 400 \text{ V},$		-	-	85	nC
Gate-Drain Charge	Q _{gd}	1	see fig. 6 and 13 ^b		-	180	
Turn-On Delay Time	t _{d(on)}	V _{GS} = 10 V		1	25	-	
Rise Time	t _r		V _{DD} = 250 V, I _D = 47 A,	-	140	-]
Turn-Off Delay Time	t _{d(off)}	$V_{DD} = 250 \text{ V}, I_D = 47 \text{ A},$ $R_G = 1.0 \Omega, \text{ see fig. } 10^{\text{b}}$		-	55	-	ns
Fall Time	t _f	1		-	74	-	
Drain-Source Body Diode Characteristic	cs		<u> </u>				
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	47	_
Pulsed Diode Forward Current ^a	I _{SM}			-	-	190	- A
Body Diode Voltage	V _{SD}	$T_J = 25 ^{\circ}\text{C}, I_S = 47 \text{A}, V_{GS} = 0 \text{V}^{\text{b}}$		-	-	1.5	V
Body Diode Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = 47 A, dl/dt = 100 A/μs ^b		-	620	940	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	14	21	μC
Body Diode Recovery Current	I _{RRM}			-	38	-	Α
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on			minated b	v I c and	[P]

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width \leq 400 μ s; duty cycle \leq 2 %. c. C_{oss} eff. is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DS} .



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

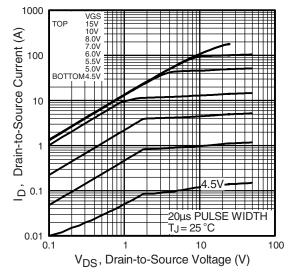


Fig. 1 - Typical Output Characteristics

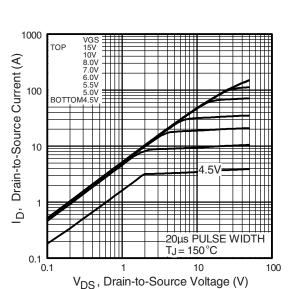


Fig. 2 - Typical Output Characteristics

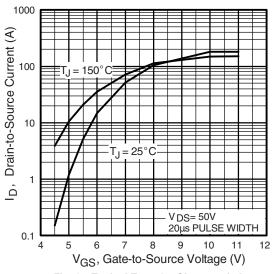


Fig. 3 - Typical Transfer Characteristics

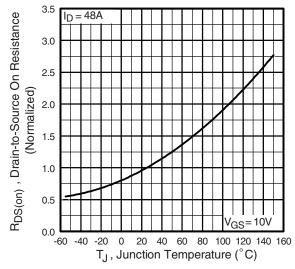


Fig. 4 - Normalized On-Resistance vs. Temperature

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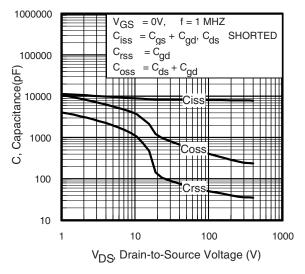


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

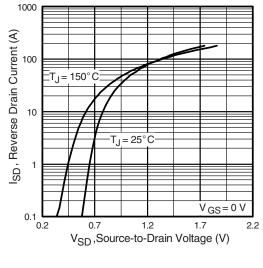


Fig. 7 - Typical Source-Drain Diode Forward Voltage

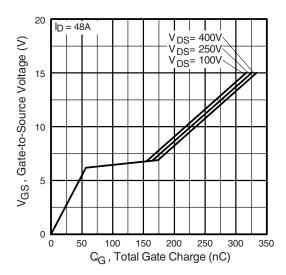


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

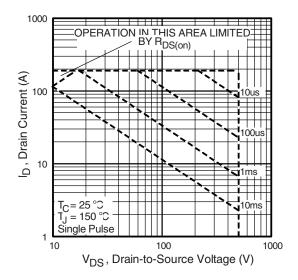


Fig. 8 - Maximum Safe Operating Area

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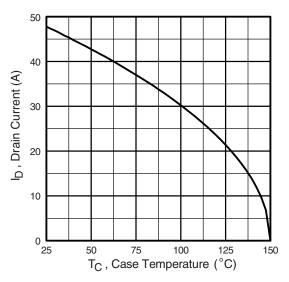


Fig. 9 - Maximum Drain Current vs. Case Temperature

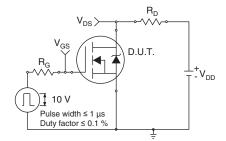


Fig. 10a - Switching Time Test Circuit

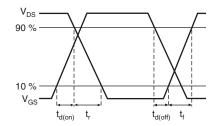


Fig. 10b - Switching Time Waveforms

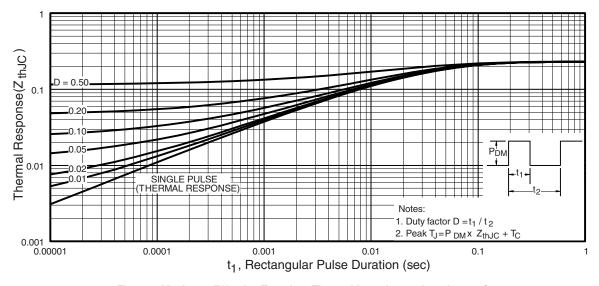
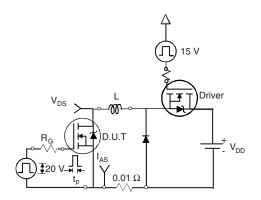


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case





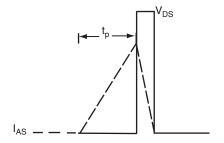


Fig. 12a - Unclamped Inductive Test Circuit

Fig. 12b - Unclamped Inductive Waveforms

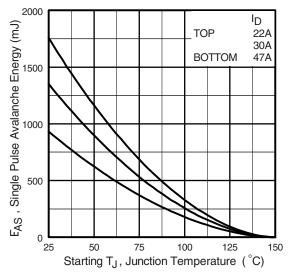


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

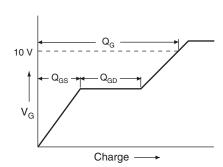


Fig. 13a - Basic Gate Charge Waveform

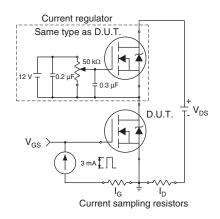
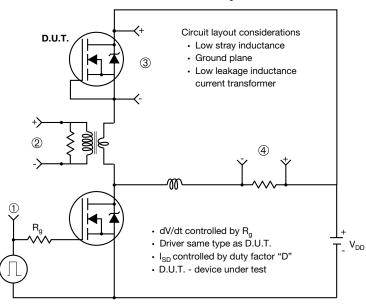


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



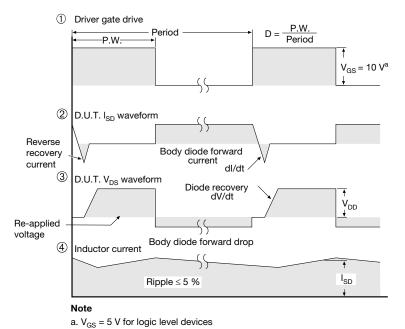
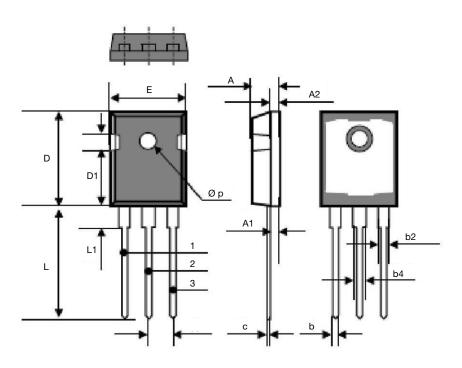


Fig. 14 - For N-Channel

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DIM.	MILLIN	METERS	INC	HES
	MIN.	MAX.	MIN.	MAX.
А	4.70	5.31	0.185	0.209
A1	2.21	2.59	0.087	0.102
A2	1.50	2.49	0.059	0.098
b	0.99	1.40	0.039	0.055
b2	1.65	2.41	0.065	0.095
b4	2.59	3.43	0.102	0.135
С	0.61	BSC	0.024	BSC
D	20.80	21.46	0.819	0.845
D1	3.68	5.49	0.145	0.216
(e)	5.46	BSC	0.215	BSC
E	15.49	16.26	0.610	0.640
L	19.81	20.32	0.780	0.800
L1	4.06	4.50	0.160	0.177
Øр	3.51	3.66	0.138	0.144



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